

# **BFQ790**

## **High Linearity RF Medium Power Amplifier**

# **Product description**

The BFQ790 is a single stage high linearity high gain driver amplifier based on Infineon's reliable and cost effective NPN silicon germanium technology. Not internally matched, the BFQ790 provides flexibility in high linearity applications.

# Features

- High 3rd order intercept point OIP3 of 41 dBm @ 5 V, 250 mA in 1850 MHz and 2650 MHz Class A application circuits
- High compression point OP1dB of 27 dBm @ 5 V, 250 mA corresponding to 40% collector efficiency
- High power gain of 17 dB @ 5V, 250 mA in 1850 MHz Class A application circuit
- Exceptional ruggedness up to VSWR 10:1 at output
- High maximum RF input power PRFinmax of 18 dBm
- 100% test of proper die attach for reproducible thermal contact
- 100% DC and RF tested





# Applications

As

• high linear pre-driver amplifier, driver amplifier or power amplifier in the RF transmit chain

In

- Commercial / industrial wireless infrastructure
- ISM band wireless sensors
- Internet of Things
- Smart metering
- Automotive radio links
- Solid state Microwace ovens

Attention: ESD (Electrostatic discharge) sensitive device, observe handling precautions

# **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC47/20/22

# **Device Information**

#### Table 1Device Information

Product Name / Ordering Code	Package	Pin Configura	Marking		
BFQ790 / BFQ790H6327XTSA1	SOT89	1 = B	2 = E	3 = C	R3



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#### **Absolute Maximum Ratings**

# **1** Absolute Maximum Ratings

#### Table 2Absolute Maximum Ratings at $T_A = 25$ °C (unless otherwise specified)

Parameter	Symbol	V	alues	Unit	Note or Test Condition
		Min.	Max.		
Collector emitter voltage	V <sub>CE</sub>	-	6.1	V	T <sub>A</sub> = 25°C
		-	5.1		$T_A = 40^{\circ}C$
Collector base voltage	V <sub>CB</sub>	-	18	V	-
Instantaneous total base emitter reverse voltage	V <sub>BE</sub>	-2.0	-	V	DC + RF swing
Instantaneous total collector current	i <sub>C</sub>	-	600	mA	DC + RF swing
DC collector current	Ι <sub>C</sub>	-	300	mA	-
DC base current	I <sub>B</sub>	-	10	mA	-
RF input power	P <sub>RFin</sub>	-	18	dBm	In- and output matched
Mismatch at output	VSWR	-	10:1		In compression, over all phase angles
ESD stress pulse	V <sub>ESD</sub>	-500	500	V	HBM, all pins, acc. to ANSI / ESDA / JEDEC JS-001-2012
Dissipated power	P <sub>DISS</sub>	-	1500	mW	T <sub>S</sub> ≤ 112.5 °C <sup>1)</sup> , regard derating curve in <i>Figure 1</i> .
Junction temperature	TJ	-	150	°C	-
Operating case temperature	T <sub>A</sub>	-40	105 <sup>2)</sup>	°C	-
Storage temperature	T <sub>Stg</sub>	-55	150	°C	-

Attention: Stresses above the max. values listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability. Maximum ratings are absolute ratings; exceeding only one of these values may cause irreversible damage to the component.

<sup>2</sup> At the same time regard  $T_{J,max}$ .

 $T_{S}$  is the soldering point temperature.  $T_{S}$  is measured on the emitter lead at the soldering point of the pcb.



#### **Recommended Operating Conditions**

#### 2

# **Recommended Operating Conditions**

This following table shows examples of recommended operating conditions. As long as maximum ratings are regarded operation outside these conditions is permitted, but increases failure rate and reduces lifetime. For further information refer to the quality report available on the BFQ790 internet page.

Operating Mode	Ambient Temperat ure <sup>1)</sup>	Collector Current	DC Power <sup>2)</sup>	RF Output Power <sup>3)</sup>	Efficiency 4)	Dissipate d Power <sup>5)</sup>	Thermal Resistanc e of pcb <sup>6)</sup>	Junction Temperat ure <sup>7)</sup>
	T <sub>A</sub> [°C]	I <sub>C</sub> [mA]	P <sub>DC</sub> [mW]	P <sub>RFout</sub> [mW] (dBm)	η [%]	P <sub>diss</sub> [mW]	R <sub>THSA</sub> [K/W]	T」 [°C]
Compressi on	55	250	1250	500 (27)	40	750	45	110
Final stage	55	200	1000	250 (24)	25	750	45	110
High T <sub>A</sub>	85	120	600	50 (17)	8.5	550	20	110
Maximum T <sub>A</sub>	105	50	250	100 (20)	40	150	30	110
Linear	55	150	750	50 (17)	7	700	50	110
Very Linear	55	250	1250	50 (17)	4	1200	20	110

#### Table 3 Recommended Operating Conditions

- <sup>1</sup> Is the operating case temperature respectively of the heatsink.
- <sup>2</sup>  $P_{DC} = V_{CE}^* I_C$  with  $V_{CE} = 5 V$ .
- <sup>3</sup> RF power delivered to the load,  $P_{RFout} = \eta * P_{DC}$ .
- <sup>4</sup> Efficiency of the conversion from DC power to RF power,  $\eta = P_{RFout} / P_{DC}$  (collector efficiency).
- <sup>5</sup>  $P_{diss} = P_{DC} P_{RFout}$ . The RF output power  $P_{RFout}$  delivered to the load reduces the power  $P_{diss}$  to be dissipated by the device. This means a good output match is recommended.

<sup>&</sup>lt;sup>6</sup> R<sub>THSA</sub> is the thermal resistance of the pcb including heat sink, that is between the soldering point S and the ambient A. Regard the impact of R<sub>THSA</sub> on the junction temperature T<sub>J</sub>, see below. The thermal design of the pcb, respectively R<sub>THSA</sub>, has to be adjusted to the intended operating mode.

<sup>&</sup>lt;sup>7</sup>  $T_J = T_A + P_{diss} * R_{THJA}$ .  $R_{THJA} = R_{THJS} + R_{THSA}$ .  $R_{THJA}$  is the thermal resistance between the transistor junction J and the ambient A.  $R_{THJS}$  is the combined thermal resistance of die and package, which is 25 K/W for the BFQ790,, see *Chapter 3*.



**Thermal Characteristics** 

# 3 Thermal Characteristics

#### Table 4Thermal Resistance

Parameter	Symbol	Values			Unit	Note or Test Condition
		Min.	Тур.	Max.		
Junction - soldering point	R <sub>thJS</sub>	-	25	-	K/W	-



Figure 1 Absolute Maximum Power Dissipation P<sub>diss,max</sub> vs. T<sub>s</sub>

Note: In the horizontal part of the derating curve the maximum power dissipation is given by  $P_{diss,max} \approx V_{CE,max} * I_{C,max}$ . In this part the junction temperature  $T_J$  is lower than  $T_{J,max}$ . In the declining slope it is  $T_J = T_{J,max}$ ,  $P_{diss,max}$  has to be reduced according to the curve in order not to exceed  $T_{J,max}$ . It is  $T_{J,max} = T_S + P_{diss,max} * R_{THJS}$ .



**Electrical Performance in Test Fixture** 

# 4 Electrical Performance in Test Fixture

#### 4.1 DC Parameter Table

#### Table 5DC Characteristics at $T_A = 25$ °C

Parameter	Symbol		Values		Unit	Note or Test Condition
		Min.	Тур.	Max.		
Collector emitter breakdown voltage	V <sub>(BR)CEO</sub>	6.1	6.7	-	V	I <sub>C</sub> = 1 mA, open base
Collector emitter leakage current	I <sub>CES</sub>	-	1	40 <sup>1)</sup>	nA	V <sub>CE</sub> = 8 V, V <sub>BE</sub> = 0 V
		-	0.1	3	μA	V <sub>CE</sub> = 18 V, V <sub>BE</sub> = 0 V E-B short circuited
Collector base leakage current	I <sub>CBO</sub>	-	1	40 <sup>1)</sup>	nA	$V_{CB} = 8 V$ , $I_E = 0$ Open emitter
Emitter base leakage current	I <sub>EBO</sub>	-	1	40 <sup>1)</sup>	μA	$V_{EB} = 0.5 V$ , $I_C = 0$ Open collector
DC current gain	h <sub>FE</sub>	60	120	180		V <sub>CE</sub> = 5 V, I <sub>C</sub> = 250 mA Pulse measured <sup>2)</sup>

### 4.2 AC Parameter Tables

#### Table 6General AC Characteristics at $T_A = 25 \text{ °C}$

Parameter	Symbol		Values		Unit	<b>Note or Test Condition</b>
		Min.	Тур.	Max.		
Transition frequency	f <sub>T</sub>	-	20	-	GHz	$V_{CE} = 5 V, I_{C} = 250 mA,$ f = 0.5 GHz
Collector base capacitance	C <sub>CB</sub>	-	1.1	_	pF	V <sub>CB</sub> = 5 V, V <sub>BE</sub> = 0 V, f = 1 MHz Emitter grounded
Collector emitter capacitance	C <sub>CE</sub>	-	2.2	_	pF	V <sub>CE</sub> = 5 V, V <sub>BE</sub> = 0 V, f = 1 MHz Base grounded
Emitter base capacitance	C <sub>EB</sub>	-	9.4	-	pF	$V_{EB} = 0.5 V$ , $V_{CB} = 0 V$ , f = 1 MHz Collector grounded

<sup>&</sup>lt;sup>1</sup> Upper spec value limited by the cycle time of the 100% test.

<sup>&</sup>lt;sup>2</sup> Pulse width is 1 ms, duty cycle 10%. Regard that the current gain  $h_{FE}$  depends on the junction temperature  $T_J$  and  $T_J$  amongst others from the thermal resistance  $R_{THSA}$  of the pcb, see notes to *Table 3*. Hence the  $h_{FE}$  specified in this datasheet must not be the same as in the application. It is highly recommended to apply circuit design techniques to make the collector current  $I_C$  independent on the  $h_{FE}$  production variation and temperature effects.



#### **Electrical Performance in Test Fixture**

Measurement setup for the AC characteristics shown in *Table 7* to *Table 10* is a test fixture with Bias T's and tuners to adjust the source and load impedances in a 50  $\Omega$  system, T<sub>A</sub> = 25 °C.



#### Figure 2 BFQ790 Testing Circuit

#### Table 7AC Characteristics, V<sub>CE</sub> = 5 V, f = 0.9 GHz

Parameter	Symbol		Symbol Values			Note or Test Condition
		Min.	Тур.	Max.		
Power Gain					dB	
Maximum power gain	G <sub>ms</sub>	-	23	-		I <sub>C</sub> = 250 mA
Transducer gain	S <sub>21</sub>   <sup>2</sup>	-	13	-		I <sub>C</sub> = 250 mA I <sub>C</sub> = 250 mA
Minimum Noise Figure					dB	Z <sub>S</sub> = Z <sub>Sopt</sub>
Minimum noise figure	NF <sub>min</sub>	-	2.5	-		Z <sub>S</sub> = Z <sub>Sopt</sub> I <sub>C</sub> = 70 mA
Linearity					dBm	$Z_L = Z_{Lopt}$
1 dB compression point at output	OP1dB	-	27	-		$Z_L = Z_{Lopt}$ $I_C = 250 \text{ mA}$
3rd order intercept point at output	OIP3	-	38.5	-		I <sub>C</sub> = 250 mA

#### Table 8AC Characteristics, V<sub>CE</sub> = 5 V, f = 1.8 GHz

Parameter	Symbol		Values		Unit	Note or Test Condition
		Min.	Тур.	Max.		
Power Gain					dB	
Maximum power gain	G <sub>ms</sub>	-	18.5	_		I <sub>C</sub> = 250 mA
Transducer gain	$ S_{21} ^2$	-	7.5	-		I <sub>C</sub> = 250 mA I <sub>C</sub> = 250 mA
Minimum Noise Figure					dB	Z <sub>S</sub> = Z <sub>Sopt</sub>
Minimum noise figure	NF <sub>min</sub>	-	2.6	_		$Z_S = Z_{Sopt}$ $I_C = 70 \text{ mA}$
Linearity					dBm	$Z_L = Z_{Lopt}$
1 dB compression point at output	OP1dB	-	27	-		$Z_L = Z_{Lopt}$ $I_C = 250 \text{ mA}$ $I_C = 250 \text{ mA}$
3rd order intercept point at output	OIP3	-	38.5	_		I <sub>C</sub> = 250 mA



#### **Electrical Performance in Test Fixture**

#### Table 9AC Characteristics, V<sub>CE</sub> = 5 V, f = 2.6 GHz

Parameter	Symbol		Values		Unit	Note or Test Condition
		Min.	Тур.	Max.		
Power Gain					dB	
Maximum power gain	G <sub>ms</sub>	-	16	-		I <sub>C</sub> = 250 mA
Transducer gain	S <sub>21</sub>   <sup>2</sup>	-	5.5	-		I <sub>C</sub> = 250 mA
Minimum Noise Figure					dB	Z <sub>S</sub> = Z <sub>Sopt</sub>
Minimum noise figure	NF <sub>min</sub>	-	3.0	-		Z <sub>S</sub> = Z <sub>Sopt</sub> I <sub>C</sub> = 70 mA
Linearity					dBm	$Z_L = Z_{Lopt}$
1 dB compression point at output	OP1dB	-	27	-		$Z_L = Z_{Lopt}$ $I_C = 250 \text{ mA}$
3rd order intercept point at output	OIP3	-	38.5	-		I <sub>C</sub> = 250 mA

#### Table 10 AC Characteristics, $V_{CE} = 5 V$ , f = 3.5 GHz

Parameter	Symbol		Values		Unit	Note or Test Condition
		Min.	Тур.	Max.		
Power Gain					dB	
Maximum power gain	G <sub>ms</sub>	-	13	-		I <sub>C</sub> = 250 mA
Transducer gain	$ S_{21} ^2$	-	3	-		I <sub>C</sub> = 250 mA
Minimum Noise Figure					dB	Z <sub>S</sub> = Z <sub>Sopt</sub>
Minimum noise figure	NF <sub>min</sub>	-	3.4	-		$Z_S = Z_{Sopt}$ $I_C = 70 \text{ mA}$
Linearity					dBm	$Z_L = Z_{Lopt}$
1 dB compression point at output	OP1dB	-	27	-		$Z_L = Z_{Lopt}$ $I_C = 250 \text{ mA}$
3rd order intercept point at output	OIP3	-	38.5	-		I <sub>C</sub> = 250 mA



#### **Electrical Performance in Test Fixture**





#### Figure 3 Collector Current $I_C$ vs. $V_{CE}$ , $I_B$ = Parameter

Note: Regard absolute maximum ratings for I<sub>C</sub>, V<sub>CE</sub> and P<sub>diss</sub>



Figure 4 DC Current Gain  $h_{FE}$  vs.  $I_C$  at  $V_{CE}$  = 5 V



#### **Electrical Performance in Test Fixture**



#### Figure 5 Collector Emitter Breakdown Voltage BV<sub>CER</sub> vs. Resistor R\_B/GND

Note: The above figure shows the collector-emitter breakdown voltage BVCER with a resistor R\_B/GND between base and emitter. Only for very high R\_B/GND values ("open base") the breakdown voltage is as low as BVCEO (here 6.7 V). With decreasing R\_B/GND values BVCER increases, e.g. at R\_B/GND=10 kOhm to BVCER=10 V. In the application the biasing base resistance together with block capacitors take over the function of R\_B/GND and allows the RF voltage amplitude to swing up to voltages much higher than BVCEO, no clipping occurs. Due to this effect the transistor can be biased at VCE=5 V and still high RF output powers achieved, see the OP1dB values reported in **Chapter 4.2**.







Figure 6 Transition Frequency  $f_T$  vs.  $I_C$ ,  $V_{CE}$  = Parameter



Figure 7 Collector Base Capacitance  $C_{CB}$  vs.  $I_C$  at f = 30 MHz,  $V_{CB}$  = Parameter





Figure 8 Gain Gms, Gma,  $|S_{21}|^2$  vs. f at  $V_{CE} = 5 V$ ,  $I_C = 250 \text{ mA}$ 



Figure 9 Maximum Power Gain Gmax vs.  $I_c$  at  $V_{CE}$  = 5 V, f = Parameter





Figure 10 Maximum Power Gain Gmax vs.  $V_{CE}$  at  $I_C = 250$  mA, f = Parameter



Figure 11 Output Reflection Coefficient  $S_{22}$  vs. f at  $V_{CE}$  = 5 V,  $I_C$  = Parameter





Figure 12 Input Reflection Coefficient  $S_{11}$  vs. f at  $V_{CE}$  = 5 V,  $I_C$  = Parameter



Figure 13 Source Impedance  $Z_{Sopt}$  for Minimum Noise Figure vs. f at  $V_{CE}$  = 5V,  $I_C$  = Parameter





Figure 14 Noise Figure NF<sub>min</sub> vs. f at  $V_{CE}$  = 5 V, ZS =  $Z_{Sopt}$ ,  $I_C$  = Parameter



Figure 15 Noise Figure NF<sub>min</sub> vs. IC at  $V_{CE}$  = 5 V,  $Z_S$  =  $Z_{Sopt}$ , f = Parameter





Figure 16 Noise Figure NF<sub>50</sub> vs. IC at  $V_{CE}$  = 5 V,  $Z_S$  = 50  $\Omega$ , f = Parameter



Figure 17 Load Pull Contour OP1dB [dBm] at  $V_{CE}$  = 5 V,  $I_C$  = 250 mA, f = 0.9 GHz,  $Z_I$  =  $Z_{opt}$ 





Figure 18 Load Pull Contour OIP3 [dBm] at  $V_{CE}$  = 5 V,  $I_C$  = 250 mA, f = 0.9 GHz,  $Z_I$  =  $Z_{opt}$ 



Figure 19 Load Pull Contour Gain G [dB] at  $V_{CE}$  = 5 V,  $I_C$  = 250 mA, f = 0.9 GHz,  $Z_I$  =  $Z_{opt}$ 





Figure 20  $P_{out}$ , Gain, I<sub>C</sub>, PAE vs.  $P_{in}$  at  $V_{CE}$  = 5 V, I<sub>Cq</sub> = 155 mA, f = 0.9 GHz, Z<sub>I</sub> = Z<sub>opt</sub>



Figure 21  $P_{out}$ , Gain, I<sub>C</sub>, PAE vs.  $P_{in}$  at  $V_{CE}$  = 5 V, I<sub>Cq</sub> = 250 mA, f = 0.9 GHz, Z<sub>I</sub> = Z<sub>opt</sub>



#### **Electrical Performance in Test Fixture**



Figure 22  $P_{out}$ , Gain, I<sub>C</sub>, PAE vs.  $P_{in}$  at  $V_{CE}$  = 5 V, I<sub>Cq</sub> = 250 mA, f = 2.6 GHz, Z<sub>I</sub> = Z<sub>opt</sub>



Figure 23 OIP3 vs.  $I_C$  at  $V_{CE}$  = 5 V, f = 0.9 GHz,  $Z_L$  =  $Z_{Lopt}$ 

Note: The curves shown in this chapter have been generated using typical devices but shall not be understood as a guarantee that all devices have identical characteristic curves.  $T_A = 25$  °C.



#### **Simulation Data**

# 5 Simulation Data

For the BFQ790 a large signal model exists. It is a VBIC model, which is an advancement of the SPICE Gummel-Poon model. It covers properties of a power transistor which are not known by the standard SPICE Gummel-Poon model, such as self-heating, quasi-saturation and voltage breakdown. The VBIC model can be used in standard simulation tools such as ADS and MWO as easily as the SPICE Gummel-Poon model. On the BFQ790 internet page the VBIC model is provided as a netlist. The model already contains the package parasitics and is ready to use for DC and high frequency simulations. Besides the DC characteristics all S-parameters in magnitude and phase, noise figure (including optimum source impedance and equivalent noise resistance), intermodulation and compression have been extracted.

On the BFQ790 internet page you also find the S-parameters (including noise parameters) for linear simulation. In any case please consult our website and download the latest versions before actually starting your design.



Package Information SOT89





Figure 24 Package Outline (dimension in mm)



#### Figure 25 Package Footprint (dimension in mm)



#### Figure 26 Marking Example (marking BFQ790: R3)



Figure 27 Tape Dimensions (dimension in mm)



**Revision History** 

# **Revision History**

Major changes since previous revision

<b>Revision Histo</b>	bry
Reference	Description
Revision Histo	ry: 2014-08-26, Revision 2.0
	Preliminary datasheet based on measurements of engineering samples, replaces target datasheet.

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